AAT7551
20V P-Channel Power MOSFET

General Description

The AAT7551 is a dual low threshold P-channel MOSFET designed for the battery, cell phone, and PDA markets. Using AnalogicTech's ultra-high-density MOSFET process and space-saving, small outline, J-lead package, performance superior to that normally found in a TSOP-6 footprint has been squeezed into the footprint of an SC70JW-8 package.

Applications

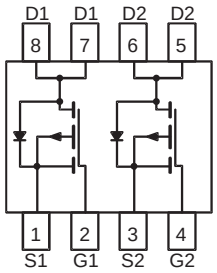
- Battery Packs
- Battery-Powered Portable Equipment
- Cellular and Cordless Telephones

Features

- Drain-Source Voltage (max): -20V
- Continuous Drain Current[1] (max): -2.7A @ 25°C
- Low On-Resistance:
  - 100mΩ @ V_{GS} = -4.5V
  - 175mΩ @ V_{GS} = -2.5V

Dual SC70JW-8 Package

Top View



Absolute Maximum Ratings

T_A = 25°C, unless otherwise noted.

Symbol	Description		Value	Units
V_{DS}	Drain-Source Voltage		-20	V
V_{GS}	Gate-Source Voltage		±12	
I_D	Continuous Drain Current @ T_J = 150°C[1]	T_A = 25°C	±2.7	A
		T_A = 70°C	±2.2	
I_{DM}	Pulsed Drain Current[2]		±8	
I_S	Continuous Source Current (Source-Drain Diode)[1]		-0.6	
T_J	Operating Junction Temperature Range		-55 to 150	°C
T_{STG}	Storage Temperature Range		-55 to 150	°C

Thermal Characteristics[1]

Symbol	Description		Typ	Max	Units
$R_{\theta JA}$	Junction-to-Ambient Steady State		132	165	°C/W
$R_{\theta JA2}$	Junction-to-Ambient t<5 Seconds		83	104	
$R_{\theta JF}$	Junction-to-Foot		60	72	
P_D	Maximum Power Dissipation	T_A = 25°C		1.2	W
		T_A = 70°C		0.75	

1. Based on thermal dissipation from junction to ambient while mounted on a 1" x 1" PCB with optimized layout. A 5-second pulse on a 1" x 1" PCB approximates testing a device mounted on a large multi-layer PCB as in most applications. $R_{\theta JF} + R_{\theta FA} = R_{\theta JA}$ where the foot thermal reference is defined as the normal solder mounting surface of the device's leads. $R_{\theta JF}$ is guaranteed by design; however, $R_{\theta CA}$ is determined by the PCB design. Actual maximum continuous current is limited by the application's design.
2. Pulse test: Pulse Width = 300µs.

Electrical Characteristics

T_J = 25°C, unless otherwise noted.

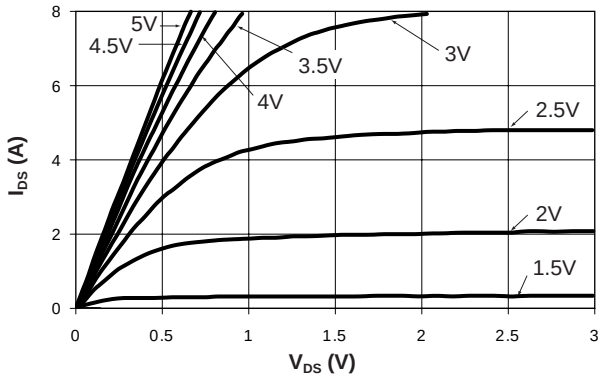
Symbol	Description	Conditions	Min	Typ	Max	Units
DC Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	V_{GS} = 0V, I_D = -250µA	-20			V
$R_{DS(ON)}$	Drain-Source On-Resistance[1]	V_{GS} = -4.5V, I_D = -2.7A		80	100	mΩ
		V_{GS} = -2.5V, I_D = -2.0A		140	175	
$I_{D(ON)}$	On-State Drain Current[1]	V_{GS} = -4.5V, V_{DS} = -5V (pulsed)	-8			A
$V_{GS(th)}$	Gate Threshold Voltage	V_{GS} = V_{DS}, I_D = -250µA	-0.6			V
I_{GSS}	Gate-Body Leakage Current	V_{GS} = ±12V, V_{DS} = 0V			±100	nA
I_{DSS}	Drain Source Leakage Current	V_{GS} = 0V, V_{DS} = -20V			-1	µA
		V_{GS} = 0V, V_{DS} = -16V, T_J = 70°C[2]			-5	
g_{fs}	Forward Transconductance[1]	V_{DS} = -5V, I_D = -2.7A		4		S
Dynamic Characteristics[2]						
Q_G	Total Gate Charge	V_{DS} = -10V, R_D = 3.7Ω, V_{GS} = -4.5V		5.9		nC
Q_{GS}	Gate-Source Charge	V_{DS} = -10V, R_D = 3.7Ω, V_{GS} = -4.5V		1		
Q_{GD}	Gate-Drain Charge	V_{DS} = -10V, R_D = 3.7Ω, V_{GS} = -4.5V		2		
$t_{D(ON)}$	Turn-On Delay	V_{DS} = -10V, R_D = 3.7Ω, V_{GS} = -4.5V, R_G = 6Ω		22		ns
t_R	Turn-On Rise Time	V_{DS} = -10V, R_D = 3.7Ω, V_{GS} = -4.5V, R_G = 6Ω		10		
$t_{D(OFF)}$	Turn-Off Delay	V_{DS} = -10V, R_D = 3.7Ω, V_{GS} = -4.5V, R_G = 6Ω		20		
t_F	Turn-Off Fall Time	V_{DS} = -10V, R_D = 3.7Ω, V_{GS} = -4.5V, R_G = 6Ω		40		
Source-Drain Diode Characteristics						
V_{SD}	Source-Drain Forward Voltage[1]	V_{GS} = 0, I_S = -2.7A			-1.3	V
I_S	Continuous Diode Current[3]				-0.6	A

1. Pulse test: Pulse Width = 300µs.
2. Guaranteed by design. Not subject to production testing.
3. Based on thermal dissipation from junction to ambient while mounted on a 1" x 1" PCB with optimized layout. A 5-second pulse on a 1" x 1" PCB approximates testing a device mounted on a large multi-layer PCB as in most applications. $R_{\theta JF} + R_{\theta FA} = R_{\theta JA}$ where the foot thermal reference is defined as the normal solder mounting surface of the device's leads. $R_{\theta JF}$ is guaranteed by design; however, $R_{\theta CA}$ is determined by the PCB design. Actual maximum continuous current is limited by the application's design.

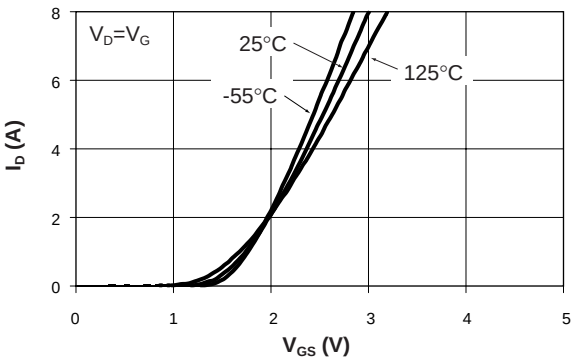
Typical Characteristics

T_J = 25ºC, unless otherwise noted.

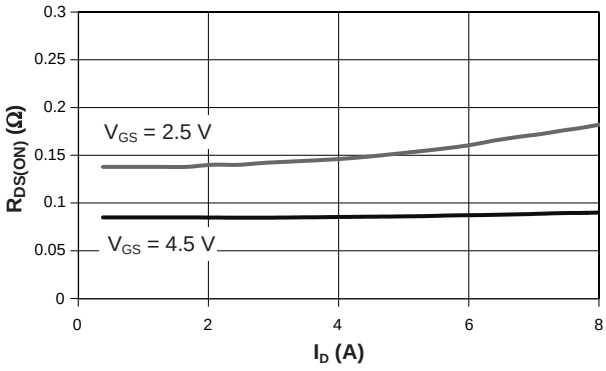
Output Characteristics



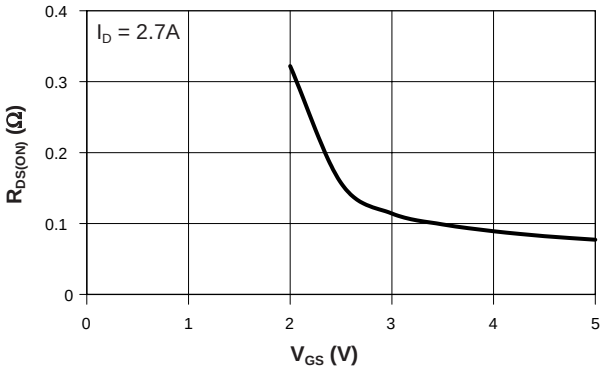
Transfer Characteristics



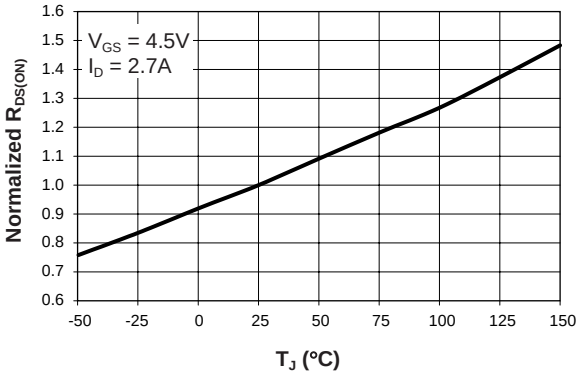
On-Resistance vs. Drain Current



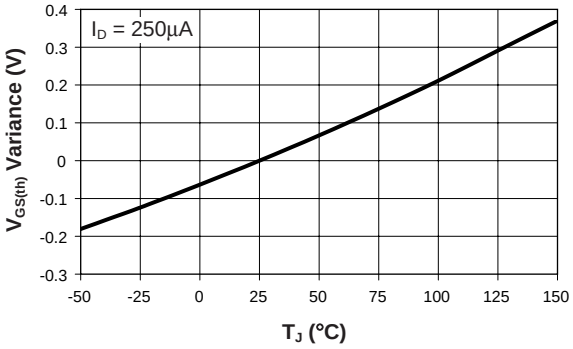
On-Resistance vs. Gate-to-Source Voltage



On-Resistance vs. Junction Temperature



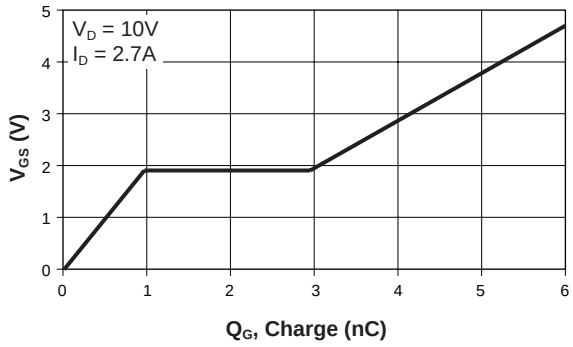
Threshold Voltage



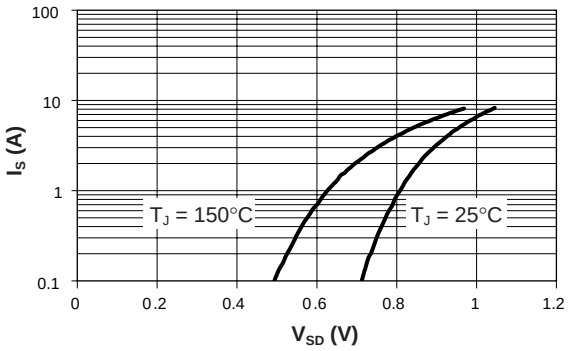
Typical Characteristics

T_J = 25ºC, unless otherwise noted.

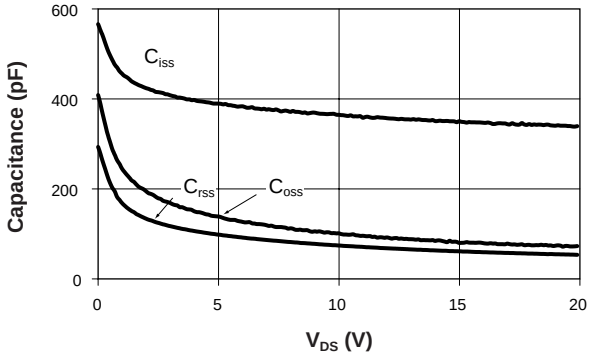
Gate Charge



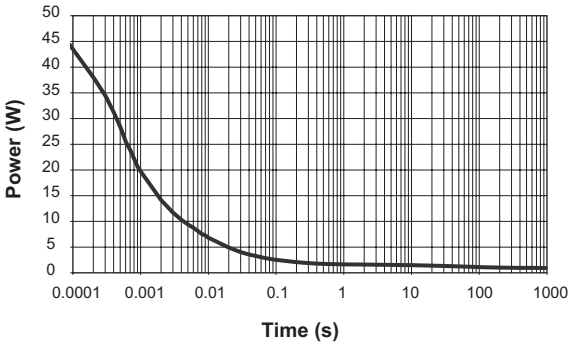
Source-Drain Diode Forward Voltage



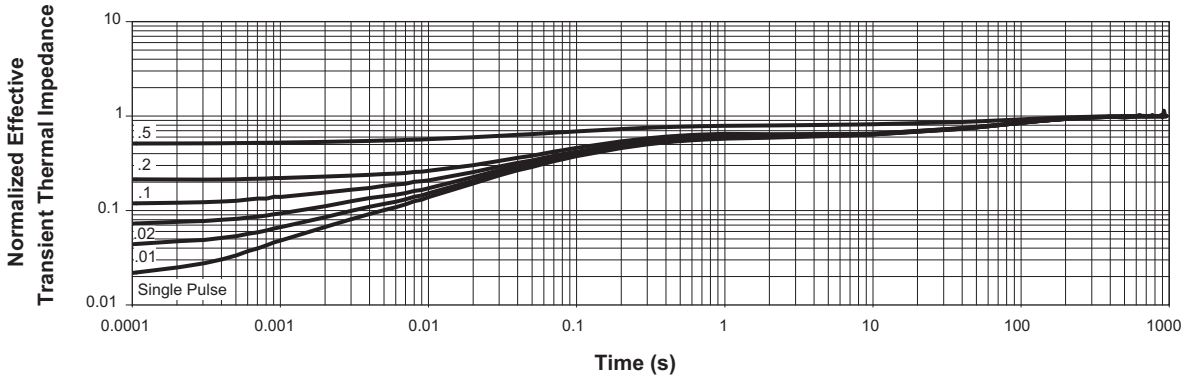
Capacitance



Single Pulse Power, Junction to Ambient



Transient Thermal Response, Junction to Ambient

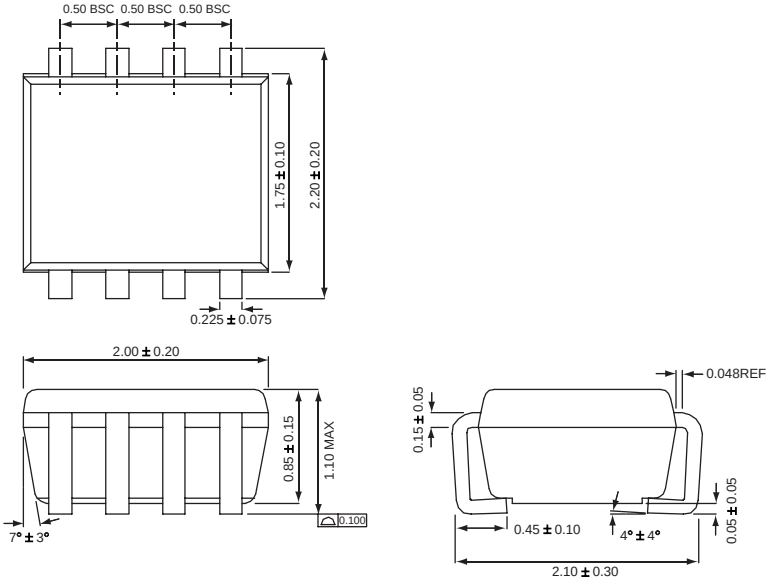


Ordering Information

Package	Marking[1]	Part Number (Tape and Reel)[2]
SC70JW-8	KDXYY	**AAT7551IJS-T1**

Package Information

SC70JW-8



All dimensions in millimeters.

1. XYY = assembly and date code.
2. Sample stock is generally held on part numbers listed in **BOLD**.

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